CT/FCT TEST PROBES

Spring-loaded test probe **GKS-075 214 064 A 2800 C** Item GKS-075-0183





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures

General data

Product aroup ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe Series GKS-075 Grid 1.91 mm [75 mil] Contacting from Pad, Pin, Post Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No KS-075 Compatible receptacle(s) - 100 °C [- 212 °F] Min. temperature Max. temperature + 200 °C [+ 392 °F] RoHS-compliant RoHS-3;6a



Electrical data

Current load capacity / rated current 3 A
Typical resistance (Ri) <100 mOhm



 Total length
 33.1 mm [1.30 in]

 Barrel diameter
 1.02 mm [.040 in]

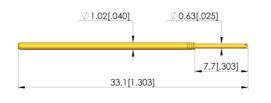
 Maximum stroke
 6.35 mm [.25 in]

 Spring pre-load
 0.65 N [2.33 ozf]

 Collar height
 00

 Spring force at working stroke
 2.8 N [10.0 ozf]

 Recommended working stroke
 4.3 mm [.169 in]



Tip style data

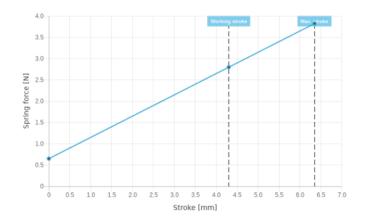
Tip style 14 4-point crown, self-cleaning
Tip diameter 0.64 mm [.025 in]
Tip style surface A gold
Tip style material 2 steel



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Learn more about ICT/FCT Test probes

